

# N-Channel 80 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)Max.$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
80	0.0028 at V <sub>GS</sub> = 10 V	100	64 nC			
	0.0048 at V <sub>GS</sub> = 4.5 V	80	04110			

#### **FEATURES**

- DT-Trench Power MOSFET
- 100 %  $R_q$  and UIS Tested



#### **APPLICATIONS**

- Primary Side Switch
- Isolated DC/DC Converters
- Full Bridge

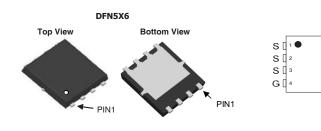
8 D

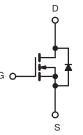
7 D

6 D

5 D

Synchonous Rectification





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	$T_A = 25  ^{\circ}C$ , unle	ess otherwise n	oted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	80	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	<b>v</b>		
	T <sub>C</sub> = 25 °C		100 <sup>a</sup>		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C		80 <sup>a</sup>		
Continuous Diam Current (1) = 130 C)	T <sub>A</sub> = 25 °C	l <sub>D</sub> –	37b,c		
	T <sub>A</sub> = 70 °C		29b,c	^	
Pulsed Drain Current (t = 300 μs)	•	I <sub>DM</sub>	400	A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	100 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	ls -	9.9 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	75		
Single Pulse Avalanche Energy	L=0.1 IIII	E <sub>AS</sub>	389	mJ	
	T <sub>C</sub> = 25 °C		225	W	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	158		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' <sup>D</sup>	<b>8</b> <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		5.6 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	$R_{thJA}$	14	23	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	0.5	1.0	O/ VV		

#### Notes:

- a. Package limited.b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile. The DFN5X6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 65  $^{\circ}\text{C/W}.$



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	•			•		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		37		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 <sub>D</sub> = 200 μΛ		- 5.6		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Cata Valta da Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V			1	μA
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		0.0028	0.0035	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 25 \text{ A}$		0.0036	0.0047	Ω
	, ,	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0048	0.0060	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 64 V, I <sub>D</sub> = 20 A		93		S
Dynamic <sup>b</sup>			l			
Input Capacitance	C <sub>iss</sub>			9289		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		590		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	<i>b</i>		68		
The residence of the re	- 133	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		64	130	
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 7.5 V, I <sub>D</sub> = 25 A		56	85	nC
Ğ		50 7 60 7 5		44		
Gate-Source Charge		$V_{DS} = 64 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		16.8		
Gate-Drain Charge	Q <sub>gd</sub>			14		
Output Charge	Q <sub>oss</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		70	105	
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.3	1	2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15		
Rise Time	t <sub>r</sub>	$V_{DD} = 64 \text{ V}, R_{L} = 4 \Omega$		10		-
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 30 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$		45		
Fall Time	t <sub>f</sub>	•		19		
Turn-On Delay Time	t <sub>d(on)</sub>			18		ns
Rise Time	t <sub>r</sub>	$V_{DD} = 64 \text{ V}, R_L = 4 \Omega$		16		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 20 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_q = 1 \Omega$		55		1
Fall Time	t <sub>f</sub>	Ç		11		
Drain-Source Body Diode Characteristic				1		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			100	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				400	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.75	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	<del>-</del>		36		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			156		nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		22		
Reverse Recovery Rise Time	t <sub>b</sub>			25		ns

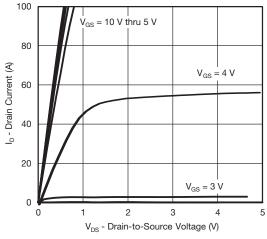
## Notes:

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

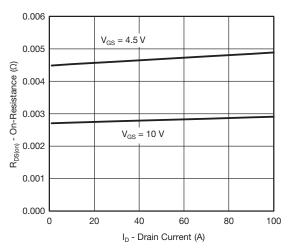
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



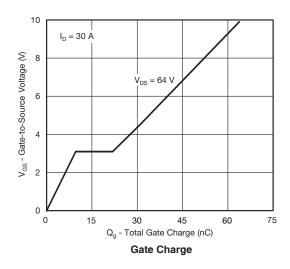
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

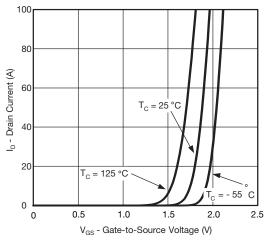


#### **Output Characteristics**

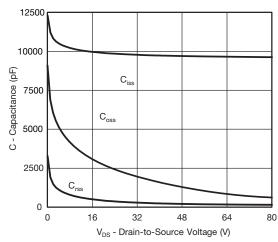


On-Resistance vs. Drain Current

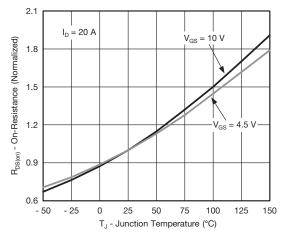




**Transfer Characteristics** 

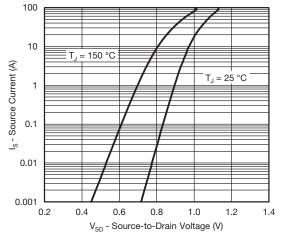


Capacitance

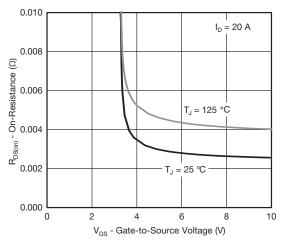


On-Resistance vs. Junction Temperature

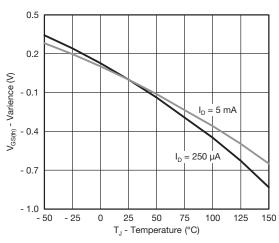
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



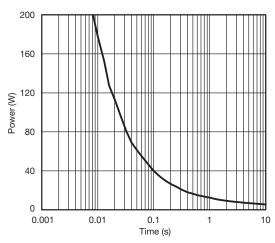
Source-Drain Diode Forward Voltage



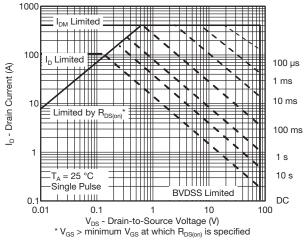
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

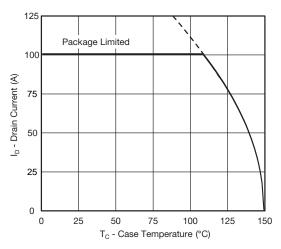


Single Pulse Power, Junction-to-Ambient

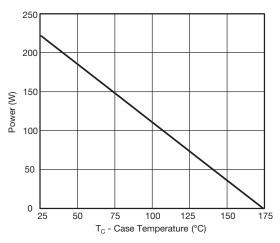


Safe Operating Area, Junction-to-Ambient

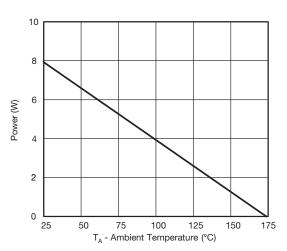
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***





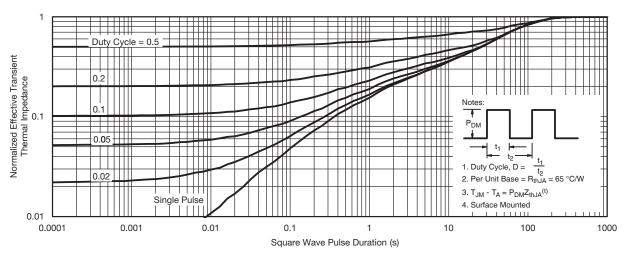


Power, Junction-to-Ambient

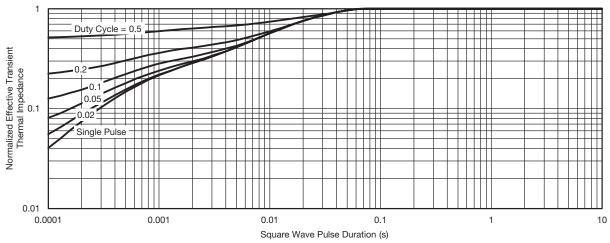
 $<sup>^{\</sup>star}$  The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150  $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

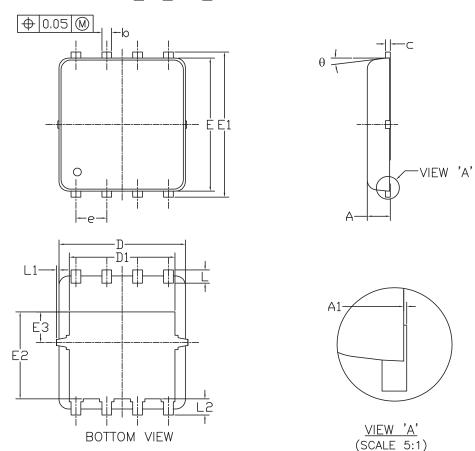


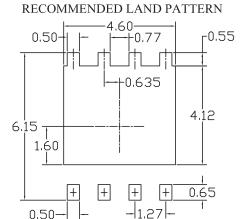
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

## DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN





SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0.95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0. 20	0. 25	0.006	0.008	0.010	
D	4. 80	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0.139	0.143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0. 050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0. 15	0		0.006	
L2	0.68 REF			0. 027 REF			
θ	0°		10°	0°		10°	

## NOTE

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



# Din-Tek SEMICONDUCTOR

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